

## STW58N60DM2AG

# Automotive-grade N-channel 600 V, 0.052 Ω typ., 50 A MDmesh™ DM2 Power MOSFET in a TO-247 package

Datasheet - production data

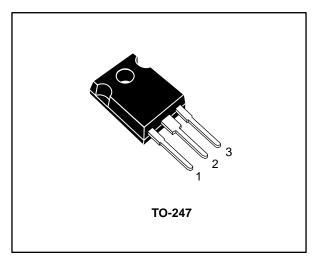
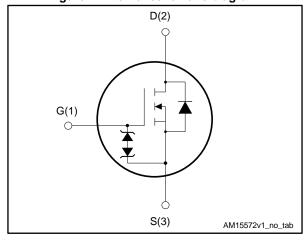


Figure 1: Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	P <sub>TOT</sub>
STW58N60DM2AG	600 V	0.060 Ω	50 A	360 W

- Designed for automotive applications and AEC-Q101 qualified
- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

#### **Applications**

Switching applications

#### **Description**

This high voltage N-channel Power MOSFET is part of the MDmesh  $^{\text{TM}}$  DM2 fast recovery diode series. It offers very low recovery charge (Q<sub>rr</sub>) and time (t<sub>rr</sub>) combined with low R<sub>DS(on)</sub>, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

**Table 1: Device summary** 

Order code	Marking	Package	Packing
STW58N60DM2AG	58N60DM2	TO-247	Tube

Contents STW58N60DM2AG

## **Contents**

1	Electric	al ratings	3
		cal characteristics	
	2.1	Electrical characteristics (curves)	6
3	Test cir	·cuits	8
4	Packag	e information	9
	4.1	TO-247 package information	9
5	Revisio	n history	11

STW58N60DM2AG Electrical ratings

## 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>GS</sub>	Gate-source voltage	±25	V
,	Drain current (continuous) at T <sub>case</sub> = 25 °C	50	۸
I <sub>D</sub>	Drain current (continuous) at T <sub>case</sub> = 100 °C	31	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed) 200		Α
P <sub>TOT</sub>	Total dissipation at T <sub>case</sub> = 25 °C 360		W
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope	50	V/ns
dv/dt <sup>(3)</sup>	MOSFET dv/dt ruggedness	50	V/IIS
T <sub>stg</sub>	Storage temperature	-55 to 150	°C
T <sub>j</sub>	Operating junction temperature	-55 (0 150	J

#### Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case	0.35	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient	50 °C/	

**Table 4: Avalanche characteristics** 

Symbol	Parameter	Value	Unit
I <sub>AS</sub> <sup>(1)</sup>	Avalanche current, repetitive or not repetitive	12	Α
E <sub>AS</sub> <sup>(2)</sup>	Single pulse avalanche energy	800	mJ

#### Notes:

 $<sup>^{\</sup>left(1\right)}$  Pulse width is limited by safe operating area.

 $<sup>^{(2)}</sup>$   $I_{SD} \leq$  50 A, di/dt=800 A/µs;  $V_{DS}$  peak <  $V_{(BR)DSS},$   $V_{DD}$  = 80%  $V_{(BR)DSS}.$ 

 $<sup>^{(3)}</sup> V_{DS} \le 480 V.$ 

 $<sup>^{(1)}</sup>$  Pulse width limited by  $T_{jmax}$ .

 $<sup>^{(2)}</sup>$  starting  $T_j = 25$  °C,  $I_D = I_{AS}, \, V_{DD} = 50$  V.

## 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	600			V
	Zoro goto voltago droin	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$			10	
I <sub>DSS</sub>	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V},$ $T_{case} = 125 \text{ °C}$			100	μΑ
I <sub>GSS</sub>	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±5	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3	4	5	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 25 A		0.052	0.060	Ω

**Table 6: Dynamic** 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	4100		
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz, V <sub>GS</sub> = 0 V	-	190	1	pF
C <sub>rss</sub>	Reverse transfer capacitance		-	3.2	ı	
C <sub>oss eq.</sub>	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$ V	-	325	ı	pF
$R_{G}$	Intrinsic gate resistance	f = 1 MHz, I <sub>D</sub> = 0 A	-	4.2	-	Ω
Qg	Total gate charge		-	90	ı	
Q <sub>gs</sub>	Gate-source charge	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 50 A, V <sub>GS</sub> = 10 V (see <i>Figure 15: "Gate charge test circuit"</i> )	-	18	ı	nC
$Q_{\text{gd}}$	Gate-drain charge		-	44	-	

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 25 \text{ A R}_G = 4.7 \Omega \text{ (see}$	-	24	-	
t <sub>r</sub>	Rise time	Figure 14: "Switching times test circuit for	ı	60	ı	
t <sub>d(off)</sub>	Turn-off delay time	resistive load" and Figure 19: "Switching time waveform")	- 1	130	ı	ns
t <sub>f</sub>	Fall time		-	12		

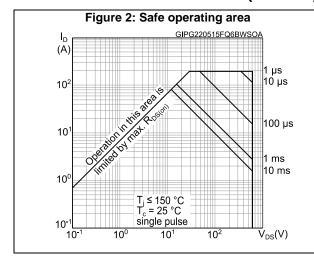
Table 8: Source-drain diode

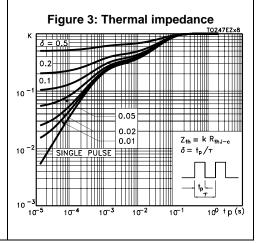
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		50	А
I <sub>SDM</sub>	Source-drain current (pulsed)		-		200	А
V <sub>SD</sub> <sup>(1)</sup>	Forward on voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 50 A	1		1.6	V
t <sub>rr</sub>	Reverse recovery time		-	140		ns
Q <sub>rr</sub>	Reverse recovery charge	$I_{SD}$ = 50 A, di/dt = 100 A/ $\mu$ s, $V_{DD}$ = 60 V (see Figure 16: "Test circuit for inductive load switching and diode recovery times")		0.7		μC
I <sub>RRM</sub>	Reverse recovery current			10.6		А
t <sub>rr</sub>	Reverse recovery time		-	245		ns
Q <sub>rr</sub>	Reverse recovery charge	$I_{SD}$ = 50 A, di/dt = 100 A/ $\mu$ s, $V_{DD}$ = 60 V, $T_{j}$ = 150 °C (see Figure 16: "Test circuit for inductive load switching and diode		2.6		μC
I <sub>RRM</sub>	Reverse recovery current	recovery times")	-	21		А

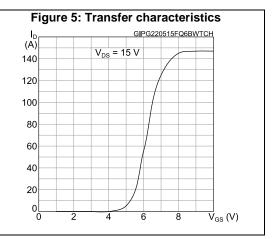
#### Notes:

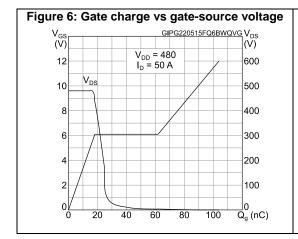
 $<sup>^{(1)}</sup>$  Pulse test: pulse duration = 300  $\mu s,$  duty cycle 1.5%.

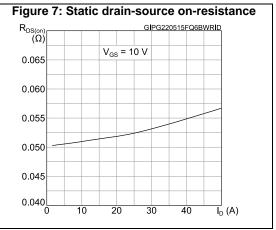
#### 2.1 Electrical characteristics (curves)











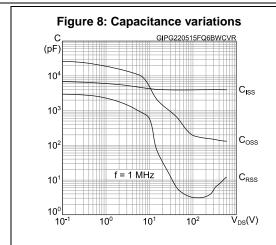


Figure 10: Normalized on-resistance vs temperature

R<sub>DS(on)</sub> GIPG220515FQ6BWRON
(norm.)

2.2

1.8

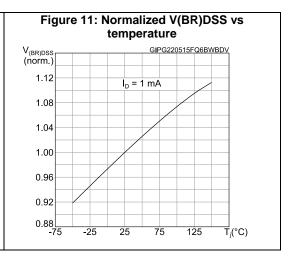
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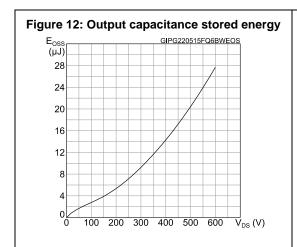
1.0

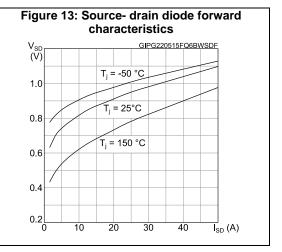
0.6

0.2

-75
-25
25
75
125
T<sub>j</sub> (°C)





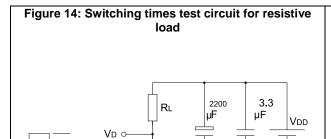


Test circuits STW58N60DM2AG

AM01468v1

AM01470v1

### 3 Test circuits



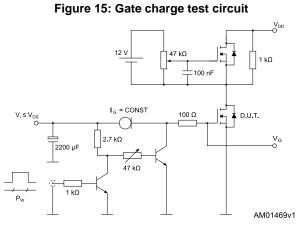


Figure 17: Unclamped inductive load test circuit

VD

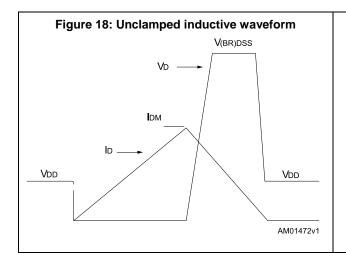
2200

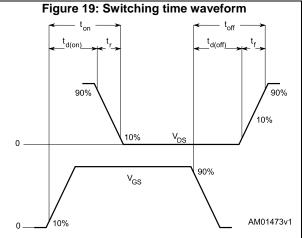
µF

VD

VD

AM01471v1





577

## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

#### 4.1 TO-247 package information

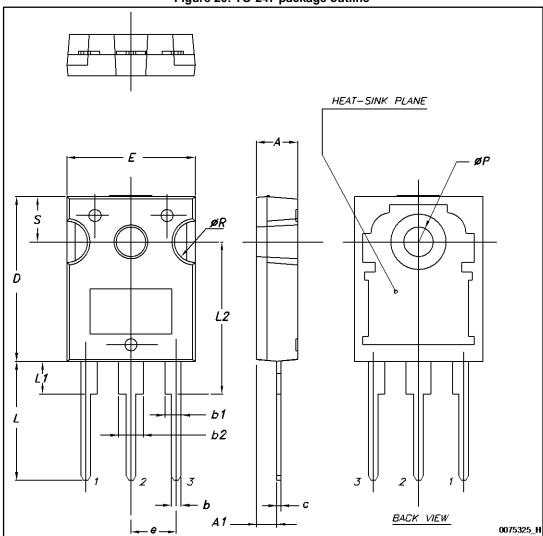


Figure 20: TO-247 package outline

Table 9: TO-247 package mechanical data

Dim		mm.	
Dim.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
Е	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

STW58N60DM2AG Revision history

# 5 Revision history

**Table 10: Document revision history** 

Date	Revision	Changes
12-Jun-2015	1	First release.
20-Jul-2015	2	Updated title and features. Minor text changes.

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